

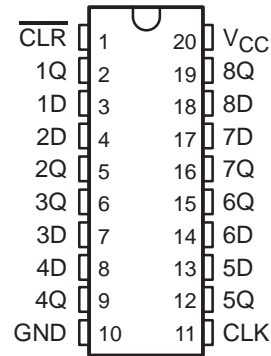
CD74FCT273

BiCMOS OCTAL D-TYPE FLIP-FLOP WITH RESET

SCBS737A – JULY 2000 – REVISED JULY 2000

- BiCMOS Technology With Low Quiescent Power
- Buffered Inputs
- Direct Clear Input
- 48-mA Output Sink Current
- Output Voltage Swing Limited to 3.7 V
- Controlled Output Edge Rates
- Input/Output Isolation From V_{CC}
- SCR Latch-Up-Resistant BiCMOS Process and Circuit Design
- Applications Include:
 - Buffer/Storage Registers
 - Shift Registers
 - Pattern Generators
- Package Options Include Plastic Small-Outline (M) Package and Standard Plastic (E) DIP

E OR M PACKAGE
(TOP VIEW)



description

The CD74FCT273 is a positive-edge-triggered, D-type flip-flop with a direct clear ($\overline{\text{CLR}}$) input. This device uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output high level to two diode drops below V_{CC} . This resultant lowering of output swing (0 V to 3.7 V) reduces power-bus ringing [a source of electromagnetic interference (EMI)] and minimizes V_{CC} bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 48 mA.

Information at the data (D) inputs meeting the setup time requirements is transferred to the Q outputs on the positive-going edge of the clock (CLK) pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When CLK is at either the high or low level, the D input has no effect at the output. All eight flip-flops are controlled by a common clock (CLK) and a common reset ($\overline{\text{CLR}}$). The outputs are placed in a low state when $\overline{\text{CLR}}$ is taken low, independent of the CLK.

The CD74FCT273 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE
(each flip-flop)

| INPUTS | | | OUTPUT Q |
|-------------------------|-----|---|-------------|
| $\overline{\text{CLR}}$ | CLK | D | |
| L | X | X | L |
| H | ↑ | H | H |
| H | ↑ | L | L |
| H | L | X | Q_0 |



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

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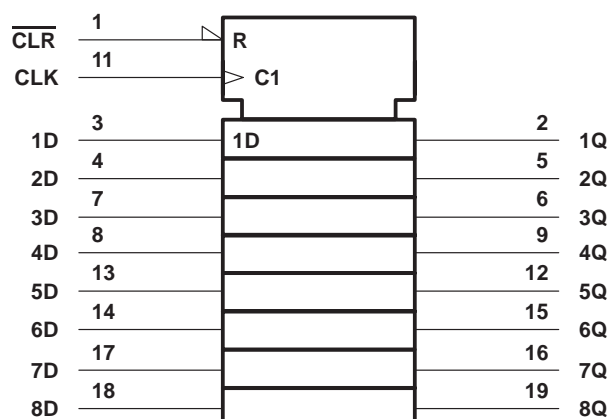
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CD74FCT273

BiCMOS OCTAL D-TYPE FLIP-FLOP WITH RESET

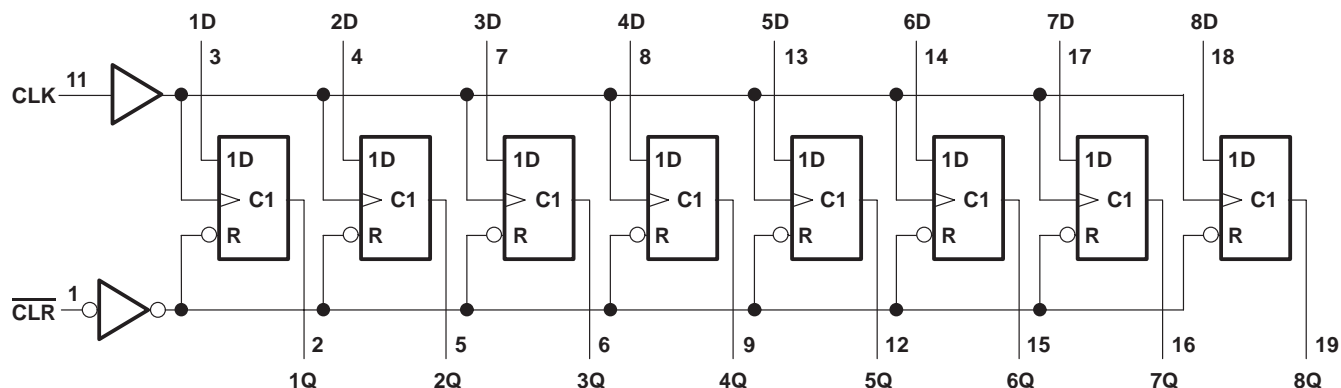
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logic symbol†

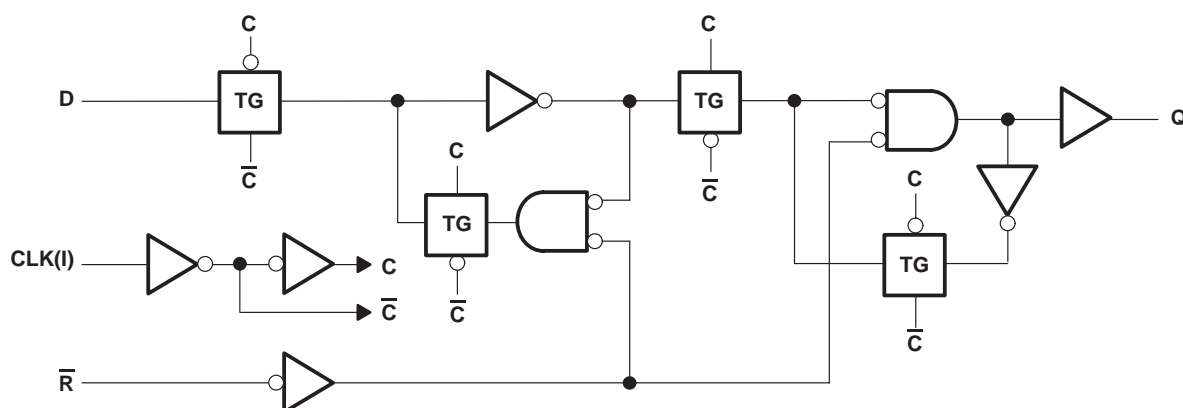


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



logic diagram, each flip-flop (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| | |
|--|----------------|
| DC supply voltage range, V_{CC} | –0.5 V to 6 V |
| DC input diode current, I_{IK} ($V_I < -0.5$ V) | –20 mA |
| DC output diode current, I_{OK} ($V_O < -0.5$ V) | –50 mA |
| DC output sink current per output pin, I_{OL} | 70 mA |
| DC output source current per output pin, I_{OH} | –30 mA |
| Continuous current through V_{CC} , I_{CC} | 140 mA |
| Continuous current through GND | 400 mA |
| Package thermal impedance, θ_{JA} (see Note 1): E package | 69°C/W |
| M package | 58°C/W |
| Storage temperature range, T_{stg} | –65°C to 150°C |

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 2)

| | MIN | MAX | UNIT |
|--|------|----------|------|
| V_{CC} Supply voltage | 4.75 | 5.25 | V |
| V_{IH} High-level input voltage | 2 | | V |
| V_{IL} Low-level input voltage | | 0.8 | V |
| V_I Input voltage | 0 | V_{CC} | V |
| V_O Output voltage | 0 | V_{CC} | V |
| I_{OH} High-level output current | | –15 | mA |
| I_{OL} Low-level output current | | 48 | mA |
| $\Delta t/\Delta v$ Input transition rise or fall rate | 0 | 10 | ns/V |
| T_A Operating free-air temperature | 0 | 70 | °C |

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V_{CC} | $T_A = 25^\circ\text{C}$ | | MIN | MAX | UNIT |
|--------------------|--|----------|--------------------------|-----------|------|----------|---------------|
| | | | MIN | MAX | | | |
| V_{IK} | $I_I = -18$ mA | 4.75 V | –1.2 | | –1.2 | | V |
| V_{OH} | $I_{OH} = -15$ mA | 4.75 V | 2.4 | | 2.4 | | V |
| V_{OL} | $I_{OL} = 48$ mA | 4.75 V | | 0.55 | | 0.55 | V |
| I_I | $V_I = V_{CC}$ or GND | 5.25 V | | ± 0.1 | | ± 1 | μA |
| I_{OZ} | $V_O = V_{CC}$ or GND | 5.25 V | | ± 0.5 | | ± 10 | μA |
| I_{OS}^\ddagger | $V_I = V_{CC}$ or GND, $V_O = 0$ | 5.25 V | –60 | | –60 | | mA |
| I_{CC} | $V_I = V_{CC}$ or GND, $I_O = 0$ | 5.25 V | | 8 | | 80 | μA |
| ΔI_{CC}^\S | One input at 3.4 V, Other inputs at V_{CC} or GND | 5.25 V | | 1.6 | | 1.6 | mA |
| C_i | $V_I = V_{CC}$ or GND | | | | | 10 | pF |

† Not more than one output should be tested at a time, and the duration of the test should not exceed 100 ms.

§ This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC} .

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timing requirements over recommended operating conditions (unless otherwise noted) (see Figure 1)

| | | | MIN | MAX | UNIT |
|--------------------|-----------------|---|-----|-----|------|
| f_{clock} | Clock frequency | | | 70 | MHz |
| t_w | Pulse duration | $\overline{\text{CLR}}$ low | 7 | | ns |
| | | CLK high or low | 7 | | |
| t_{su} | Setup time | Data before CLK \uparrow | 3 | | ns |
| | | $\overline{\text{CLR}}$ before CLK \uparrow | 4 | | |
| t_h | Hold time | Data after CLK \uparrow | 2 | | ns |

switching characteristics over recommended operating conditions, $C_L = 50$ pF (unless otherwise noted) (see Figure 1)

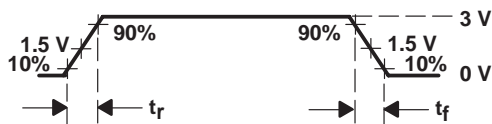
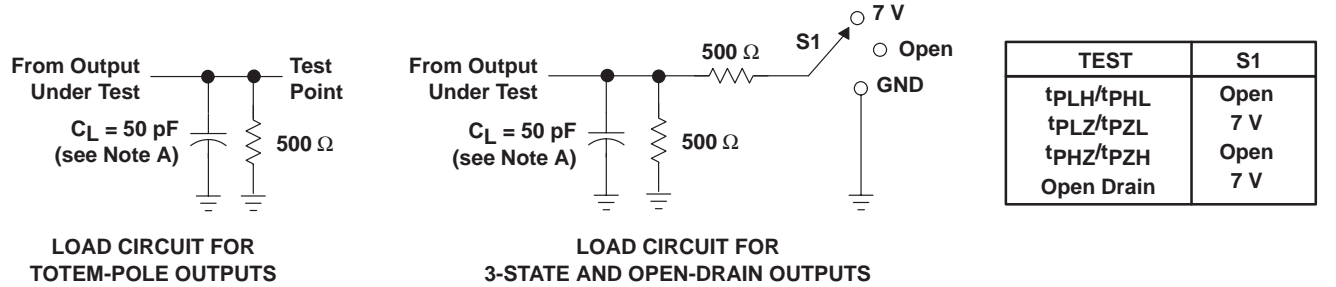
| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $T_A = 25^\circ\text{C}$ | MIN | MAX | UNIT |
|------------------|-------------------------|----------------|--------------------------|-----|-----|------|
| | | | TYP | | | |
| f_{max} | | | | 70 | | MHz |
| t_{pd} | CLK | Any Q | 7 | 2 | 13 | ns |
| | $\overline{\text{CLR}}$ | | 8 | 2 | 13 | |

operating characteristics, $T_A = 25^\circ\text{C}$

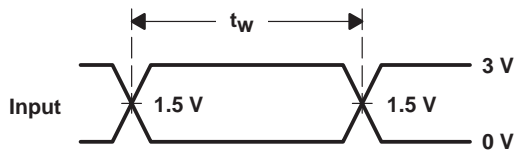
| PARAMETER | | TEST CONDITIONS | TYP | UNIT |
|-----------------|-------------------------------|----------------------|-----|------|
| C_{pd} | Power dissipation capacitance | No load, $f = 1$ MHz | 36 | pF |



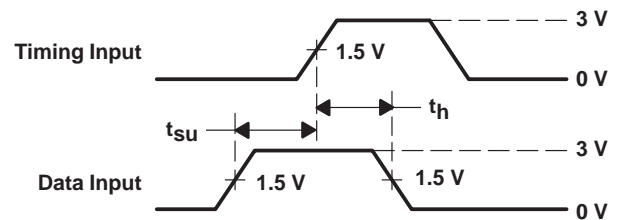
PARAMETER MEASUREMENT INFORMATION



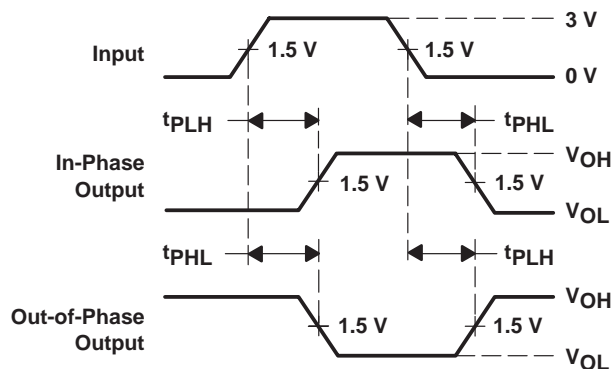
**VOLTAGE WAVEFORM
INPUT RISE AND FALL TIMES**



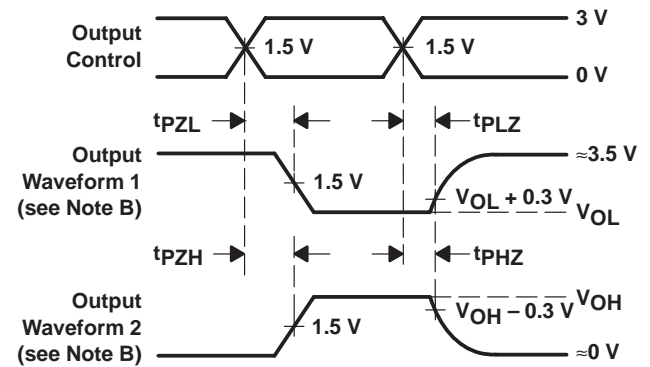
**VOLTAGE WAVEFORMS
PULSE DURATION**



**VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES**



**VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
INVERTING AND NONINVERTING OUTPUTS**



**VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES
LOW- AND HIGH-LEVEL ENABLING**

- NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1 \text{ MHz}$, $Z_O = 50 \Omega$, t_r and $t_f = 2.5 \text{ ns}$.
D. The outputs are measured one at a time with one input transition per measurement.
E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
F. t_{PZL} and t_{PZH} are the same as t_{en} .
G. t_{PHL} and t_{PLH} are the same as t_{pd} .

Figure 1. Load Circuit and Voltage Waveforms

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead/Ball Finish | MSL Peak Temp (3) | Op Temp (°C) | Top-Side Markings (4) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|----------------------------|------------------|----------------------|--------------|--------------------------|-------------------------|
| CD74FCT273E | ACTIVE | PDIP | N | 20 | 20 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | 0 to 70 | CD74FCT273E | Samples |
| CD74FCT273EE4 | ACTIVE | PDIP | N | 20 | 20 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | 0 to 70 | CD74FCT273E | Samples |
| CD74FCT273M | ACTIVE | SOIC | DW | 20 | 25 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | 0 to 70 | 74FCT273M | Samples |
| CD74FCT273ME4 | ACTIVE | SOIC | DW | 20 | 25 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | 0 to 70 | 74FCT273M | Samples |
| CD74FCT273MG4 | ACTIVE | SOIC | DW | 20 | 25 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | 0 to 70 | 74FCT273M | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



| PINS ** DIM | 14 | 16 | 18 | 20 |
|---------------------|------------------|------------------|------------------|------------------|
| A MAX | 0.775 (19,69) | 0.775 (19,69) | 0.920 (23,37) | 1.060 (26,92) |
| A MIN | 0.745 (18,92) | 0.745 (18,92) | 0.850 (21,59) | 0.940 (23,88) |
| MS-001 VARIATION | AA | BB | AC | AD |



4040049/E 12/2002

NOTES:

- A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
-  Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 The 20 pin end lead shoulder width is a vendor option, either half or full width.

DW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 - D. Falls within JEDEC MS-013 variation AC.

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